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Published in:
Proceedings of the 9th IEEE Electronics Packaging Technology Conference

Link to article, DOI:
10.1109/EPTC.2007.4469822

Publication date:
2007

Document Version
Publisher's PDF, also known as Version of record

Link back to DTU Orbit

Citation (APA):

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In-Situ Investigation of Lead-Free Solder Alloy Formation using a Hot-Plate Microscope

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Abstract
This work presents the advantages of using a hot-plate microscope for investigation of new (high-temperature) lead-free solders as in-situ analysis tool and preparation equipment. A description of the equipment and the preparation method is given and some examples are outlined. The formation of small AuSn-based, homogeneous and un-oxidized solder spheres will be demonstrated. Moreover the possibility of using this equipment as a sample preparation method to further investigation is shown. As example the equipment was used to produce samples for Vickers microhardness measurement of important phases of the Au-Sn system. The measured values are comparable to those found in the literature. An outlook to further research is also given.

Introduction
Since the European RoHS [1] came into effect in July 2006 the development of (high-temperature) lead-free solder alternatives, especially as first-level solder material [2], became more important. It is still unspecified exactly how long the exceptions, covering the Pb-rich solders [3], will be in force. Therefore an easy and fast method for preparation and investigation of new solder material combinations is needed.

In most experiments from the literature, either investigating solder materials or preparing samples for phase diagram investigations, specimens were prepared by encapsulating portions of metals (powders, granules, shots) into quartz tubes under vacuum and melting them at high temperatures. [4, 5, 6, 7, 8] In other cases alumina crucibles and induction/ electron beam melting under argon atmosphere are used to produce samples. [9, 10] A vacuum furnace was used by Law et al. [11]. Often mechanical mixing or shaking is necessary to ensure homogeneity. [5, 12, 7, 8]

Annealing steps ranging from hours to months are used to create special intermetallic phases within an alloy.

Another method to investigate phase diagrams, the microstructure or diffusion properties of a material combination is the diffusion couple technique. [13, 14, 15] The specimens produced with this technique are normally not useable for differential scanning calorimetry (DSC)/ differential thermal analysis (DTA) measurements or mechanical tests.

To form solder balls for further experiments, such as shear tests, several techniques are found in the literature. Kim et al. [5] shaped the molten alloy into a wire-type specimen, cut pieces and dropped them into hot silicon oil to form spheres (750µm). Hot-rolling of an ingot and subsequent punching into disks which were also remelted in silicon oil was used by Lee et al. [12] to make spherical balls (760µm). Cutting small pieces from an ingot and remelting (with flux) them onto an aluminum plate to produce bumps (760µm) was used by Law et al. [11]. In all cases relatively high amount of material is used to produce an ingot for further experiments. This could be very material consuming and expensive especially when Au or Ag are used in high amounts.

Moreover in the case of experimental material compositions it is not possible to use electroplating to create bumps like in normal production processes [2]. Nearly each new composition needs the development of a dedicated electroplating bath.

As an alternative method the authors will present the benefits of using a hot-plate microscope with optical in-situ investigation (image/video system) of the melting and solidification process to examine small solder spheres. As example of using the equipment as a preparation tool, samples with different compositions of Au and Sn were produced and Vickers microhardness values of important Au-Sn phase determined.

Experimental Setup
As schematically shown in Fig. 1, the hot-plate microscope equipment consists of three main parts.

1) Vacuum system
2) Specimen chamber with heating system
3) Microscope and imaging system

The essential part of the equipment is the specimen chamber in which a high-vacuum (<1x10⁻³ mbar) can be created, controlled by pressure measurement. Inside this chamber a molybdenum plate (6x8 mm) is mounted between the electrical contacts of a current heating system. The heating system can reach a temperature up to approximately 1400 °C and is equipped with water cooling. A specimen holder or crucible, up to 6mm in height, can be placed on the molybdenum plate. During heating an optional flow of reducing hydrogen gas can be applied. The chamber is sealed by a removable glass lid for optical in-situ observations. Using an Olympus SZ61 stereo-microscope, a digital camera and анаlySIS getIT imaging software, it is possible to photograph and film the specimen in-situ.
Experimental Procedure

In general metal (solder) spheres with a diameter between 0.5mm to 4.0mm will be produced and investigated using the hot-plate microscope, Fig. 2.

1) Weighting and pressing
2) Sphere forming
3) Heating and conditioning

In the first step high purity metal powders (depending on the composition) are carefully weighted (accuracy 0.1mg) and mixed inside a specially designed pressing tool (reducing the lose of material during the weighting and pressing step) to form small tablets. If the tablets are too fragile to be moved, polyethylene glycol (PEG) can be used as a binder.

Such a tablet is then melted inside a cylindrical aluminum oxide (Al₂O₃) crucible (70 µl, diameter 6mm) to form a solder sphere. Figs. 3a-f show this forming process for a eutectic 80Au20Sn (wt.%) powder mixture with the addition of a small amount of Ni.

It is necessary to use the cylindrical crucible because of the movement of the metal portion during the forming process from tablet to sphere (see Fig. 3c and Fig. 3d). Otherwise the tablet would not stay on the molybdenum plate and would also be soldered to this. The process is done under hydrogen flow to prevent further oxidation of the material and to start the reduction of the oxides on the surface of the developing sphere, cp. Fig. 3e.

As seen in Fig. 3e and Fig. 3f some non-metal impurities came out during the sphere forming process. Therefore it is necessary to take out the metal sphere of the camber and clean it. Normally it is done by washing in ethanol and drying.

After the forming process the solder sphere is placed into the chamber again and remelted in the heating and conditioning step. To prevent the soldering of the sphere to the molybdenum plate and to ensure a good flow of the hydrogen around the sphere, flat Al₂O₃ plates (6x6mm) are used to carry the specimen. Additionally the first experiments show that it is easier to observe the sphere and to remove the oxides if the sphere is placed on the plate instead of inside the crucible.

Doing so it is possible to in-situ investigate and record the melting and solidification process of a solder sphere using the microscope and the computational imaging and video system.

Fig. 1. Experimental setup

Fig. 2. Examples of metal (solder) spheres; a) Cu (1.1mm) b) 90Pb10Sn (2.1mm) c) 80Au20Sn(Ni) (3.5mm)

The experimental procedure to create such a sphere is divided into three parts:

1) Weighting and pressing
2) Sphere forming
3) Heating and conditioning

Fig. 3a-f. Forming process (eutectic 80Au20Sn powder mixture with a small amount of Ni)
Fig. 4 show a melting and solidification sequence of the solder sphere, formed in the previous forming step (Fig. 3).

Fig. 4a-f. Heating and conditioning process (eutectic 80Au20Sn powder mixture with a small amount of Ni)

As see in Figs. 3c-e the remaining oxides are merging on the liquid surface and form a small area during heating. By further heating and holding on high temperature all oxides can be reduced. In addition to the small size of the sphere, the high temperatures ensure a good homogeneity inside the material. A shiny liquid solder sphere, Fig. 3e is created which can be cooled down, Fig. 3f.

The melting and solidification can be conducted slow or fast. Using fast cooling, short processing time (10-15 min) allows for rapid screening of different compositions.

Because of the small size of the samples the spheres can easily be investigated further by scanning electron microscopy (SEM), light optical microscope (LOM), energy dispersive X-ray analysis (EDX), X-ray diffraction (XRD) or mechanical tests as shown in the following paragraphs. The weight of a solder sphere is compatible with the amounts used in DTA/DSC analyses.

Additionally the equipment can be used to produce prototype solder balls (diameter app. 500µm) of new material combinations for shear tests. In this case metal spheres produced with the hot-stage microscope are pressed or rolled (smashed in the case of brittle materials) into thin plates, cut into small pieces and remelted inside the chamber (4-6 pieces at the time) under hydrogen to prevent re-oxidation.

80Au20Sn solder sphere

To demonstrate the advantage of the hot plate microscope to create a homogeneous and oxide-free material, 144.4 mg of Au and Sn powder – a slightly hypoeutectic composition of Au16.9 Sn (wt.%) – was melted and slowly cooled down.

As seen in Fig. 5 and Fig. 6, a very homogeneous and oxide-free alloy was created after a short holding time at the liquid state under hydrogen flow. The liquid condition, the reduction of the oxides and the solidification was observed by in-situ inspection.

SEM and EDX analyses, Fig. 6, compared with the Au-Sn phase diagram, Fig. 7, revealed the presence of ζ' phase (Au5Sn) intermetallic precipitates inside an 80Au20Sn matrix. The 80Au20Sn matrix itself consists of a fine mixture (clearly visible in Fig. 6 as light and dark areas) of ζ' phase (Au5Sn) and δ phase (AuSn).

Fig. 5. LOM cross-section; bright eutectic 80Au20Sn matrix with dark ζ' phase (Au5Sn) precipitates.

Fig. 6. SEM/EDX cross-section; eutectic 80Au20Sn matrix with light ζ' phase (Au5Sn) precipitates.
Hardness Measurement of Au-Sn phases

To present the possibility of using the hot-stage microscope for sample preparation, several spheres with compositions of Au and Sn according to the Au-Sn phases ζ, ζ' (Au5Sn), δ (AuSn), ε (AuSn2) and η (AuSn3), see Au-Sn phase diagram Fig. 7, as well as eutectic 80Au20Sn (wt.%) samples were produced, following the described experimental procedure. Afterwards the spheres were prepared using standard metallographic preparation methods and SEM/EDX analysis was used to identify the developed phases inside the sphere. The microhardness measurements were carried out using a Vickers microhardness measurement system, FM-700 Future-Tech and JK Lab software.

Depending on the size of the measurable area and the hardness of the phase, loads of 1g or 10g and a dwell time of 5s was used.

The obtained hardness values (average of 10 measurements) for the Au-Sn phases were compared to results from the literature, compiled in Table 1. Chromik et al. [17] presented values measured by Berkovich nanoindentation in solid state aged diffusion couples with a maximum load between 0.7 and 9.5 mN (0.071g-0.97g) and Vickers microindentation on bulk δ (AuSn). As the microhardness values in this work are obtained in HV a conversion of the Berkovich indentation on bulk 5g to HV was used.

Ciulik and Notis [19] measured the hardness of several gold-rich phases by Vickers microindentation with a load of 50g on two-phase bulk alloys. Vicenzo et al. [20] obtained values (estimated from a given diagram) by indentation depth-load measurements with a peak load of 10mN (1.02g) on electrodeposited thick films and Ghosh et al. [21] measured the hardness of AuSn4 bulk material by microindentation (10-50g load).

In general the hardness values for the Au-Sn phases measured in this study fit well to the values obtained either by Ciulik and Notis or by Chromik. The values for ζ, ζ', ε and η are in agreement with Ciulik and Notis, especially ε. The reason for this might be the similar hardness testing method. In contrast the hardness values for δ and η fit well to the values reported by Chromik. In case of δ the very good agreement could also originate from similar testing methods, since δ also was tested by Vickers microindentation. [17]

A well known effect with hardness measurements is the possible dependence of the hardness from the applied load, i.e. indentation depth/size. The comparison of the values for the δ, ε and η phases, obtained in this study, with the numbers from literature [17, 19, 21] may support this effect for these phases.

Further the authors support the view of Chromik that the high hardness values measured by Vicenzo are due to effects (small grain size) from the electrodeposition process, as none of the measured values fit to our results.

### Table 1. Hardness values of Au-Sn phases measured in this work with values from the literature for comparison.

<table>
<thead>
<tr>
<th>Phase</th>
<th>Hardness (HV ± σ)</th>
<th>Source</th>
</tr>
</thead>
<tbody>
<tr>
<td>Au</td>
<td>66 ± 1.5, 10g</td>
<td>this work [17]</td>
</tr>
<tr>
<td></td>
<td>96 ± 9</td>
<td>[19]</td>
</tr>
<tr>
<td></td>
<td>36.5 ± 0.8</td>
<td></td>
</tr>
<tr>
<td>ζ</td>
<td>86 ± 8, 1g</td>
<td>this work [19]</td>
</tr>
<tr>
<td></td>
<td>100 ± 4</td>
<td>[20]</td>
</tr>
<tr>
<td></td>
<td>270 ± 13</td>
<td></td>
</tr>
<tr>
<td>ζ' (Au5Sn)</td>
<td>143 ± 8, 10g</td>
<td>this work [19]</td>
</tr>
<tr>
<td></td>
<td>236 ± 19</td>
<td>[20]</td>
</tr>
<tr>
<td></td>
<td>126 ± 5</td>
<td></td>
</tr>
<tr>
<td></td>
<td>178 ± 16</td>
<td></td>
</tr>
<tr>
<td>Eut. 80Au20Sn</td>
<td>177 ± 7, 10g</td>
<td>this work [17]</td>
</tr>
<tr>
<td>(ζ' + δ)</td>
<td>123 ± 19</td>
<td>[19] b)</td>
</tr>
<tr>
<td></td>
<td>133</td>
<td>[20] c)</td>
</tr>
<tr>
<td></td>
<td>211 ± 29</td>
<td></td>
</tr>
<tr>
<td>δ (AuSn)</td>
<td>107 ± 1, 10g</td>
<td>this work [17]</td>
</tr>
<tr>
<td></td>
<td>104 ± 6</td>
<td>[19]</td>
</tr>
<tr>
<td></td>
<td>146 ± 4</td>
<td>[20]</td>
</tr>
<tr>
<td></td>
<td>199 ± 19</td>
<td></td>
</tr>
<tr>
<td>ε (AuSn2)</td>
<td>207 ± 3, 10g</td>
<td>this work [17]</td>
</tr>
<tr>
<td></td>
<td>274 ± 38</td>
<td>[19]</td>
</tr>
<tr>
<td></td>
<td>206 ± 4</td>
<td></td>
</tr>
<tr>
<td>η (AuSn3)</td>
<td>87 ± 4, 10g</td>
<td>this work [17]</td>
</tr>
<tr>
<td></td>
<td>113 ± 19</td>
<td>[21] c)</td>
</tr>
<tr>
<td></td>
<td>69 ± 6</td>
<td></td>
</tr>
<tr>
<td>Sn</td>
<td>9 ± 0.5, 10g</td>
<td>this work [17]</td>
</tr>
<tr>
<td></td>
<td>24 ± 7</td>
<td>[19]</td>
</tr>
<tr>
<td></td>
<td>7 ± 0.5</td>
<td></td>
</tr>
</tbody>
</table>

a Unsere, as measured with 14.33 at% Sn
b Calculated from (ζ' + δ) percentage
c at 31.5 at% (21.7 wt.%) Sn

Further Investigation

In additional experiments 80Au20Sn-based alloys with small amounts of Ni, Co, Cu, Ag and Pt will be created to...
investigate the influence of these elements on the solder properties. The possibility to rapidly produce solder spheres of new experimental compositions will be used to evaluate the strength of several solder/UBM (Under Bump Metallization) connections and the wetability of the solders.

Conclusions
A very useful tool for (high-temperature) lead-free solder development and investigation was presented. The usability of the equipment was demonstrated using AuSn-based solders. The possibility of creating – with in-situ observation – homogenous, oxide-free solder spheres for succeeding investigations was shown. It can be stated, that the use of the hot-plate microscope to prepare samples for hardness measurement was successful, as obtained hardness values for Au-Sn phases from produced metal spheres are comparable to those found in literature.

Acknowledgments
We acknowledge the Danish Ministry of Science, Technology and Development for financial support through the innovation consortium “MatPack” (project no 07-003145).

The authors furthermore wish to thank Mr. H.C. Dam and Mr. K.Aa. Thorsen for valuable advice and assistance with the hot-stage microscope as well as the Danish Technological Institute for carrying out some of the SEM/EDX analysis.

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